

Rec'd PCT/PTO 13 MAR 2008

10/589097

(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization
International Bureau



(43) International Publication Date
22 November 2007 (22.11.2007)

PCT

(10) International Publication Number
WO 2007/133176 A2

(51) International Patent Classification:
H04L 9/28 (2006.01)

(21) International Application Number:
PCT/US2006/014794

(22) International Filing Date: 19 April 2006 (19.04.2006)

(25) Filing Language: English

(26) Publication Language: English

(30) Priority Data:
11/379,207 18 April 2006 (18.04.2006) US

(71) Applicant (for all designated States except US): **MULTI-BEAM SYSTEMS, INC.** [US/US]; 2090 Duane Avenue, Santa Clara, CA 95054-3306 (US).

(72) Inventors: **PARKER, N., William**; 2309 Romano Circle, Pleasanton, CA 94566 (US). **MILLER, s., Daniel**; 777 First Street, PMB 250, Gilroy, CA 95020 (US). **RAVI, Tirunelveli, S.**; 4243 Verdigris Circle, San Jose, CA 95134 (US).

(74) Agent: **JAFFER, David, H.**; Pillsbury Winthrop Shaw Pittman LLP, Intellectual Property Group, P.O. Box 10500, Mclean, Va 22102 (US).

(81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KM, KN, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, LY, MA, MD, MG, MK, MN, MW, MX, MZ, NA, NG, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SM, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.

(84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LS, MW, MZ, NA, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IS, IT, LT, LU, LV, MC, NL, PL, PT, RO, SE, SI, SK, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

Published:

— without international search report and to be republished upon receipt of that report

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

(54) Title: FLAT PANEL DISPLAY SUBSTRATE TESTING SYSTEM

(57) Abstract: A flat panel display substrate (FPDS) testing system configured such that prior to testing, the FPDS is loaded into a pallet to prevent breakage, and to provide electrical connections to test pads on the FPDS. The system achieves high throughput by testing FPDSs using one or more charged particle beams simultaneously with the following operations: unloading of already-tested substrates, loading of substrates ready for testing, assembly of pallets, and alignment of electrical contactors to a large number of FPDS test pads. The system design eliminates a prior art X-Y stage, and all moving electrical connections to the FPDS during testing, reducing costs and improving reliability. In one embodiment, the FPDS testing system has three subsystems: a process chamber, loadlock assembly, and pallet elevator; in another embodiment, the functions of loadlock and pallet elevator are combined to reduce system footprint.

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